

Description

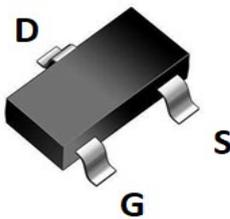
JMT P-channel Enhancement Mode Power MosFET

Features

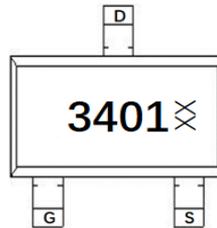
- -30V, -4.2A
 $R_{DS(ON)} < 47m\Omega @ V_{GS} = -10V$
 $R_{DS(ON)} < 53m\Omega @ V_{GS} = -4.5V$
 $R_{DS(ON)} < 68m\Omega @ V_{GS} = -2.5V$
- Advanced Trench Technology
- Excellent $R_{DS(ON)}$ and Low Gate Charge
- Lead Free

Applications

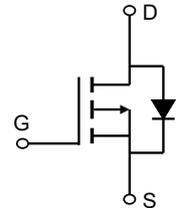
- Load Switch
- PWM Application
- Power Management



SOT-23-3L Top View



Marking and Pin Assignment



Schematic Diagram

Package Marking and Ordering Information

| Device Marking | Device | Outline | Package | Reel Size | Reel(pcs) | Per Carton (pcs) |
|----------------|-----------|---------|-----------|-----------|-----------|------------------|
| 3401 | JMTJ3401A | TAPING | SOT-23-3L | 7" | 3000 | 120000 |

Absolute Maximum Ratings (@ $T_A = 25^\circ C$ unless otherwise specified)

| Symbol | Parameter | Value | Units |
|-----------------|--|---------------------|--------------|
| V_{DS} | Drain-to-Source Voltage | -30 | V |
| V_{GS} | Gate-to-Source Voltage | ± 12 | V |
| I_D | Continuous Drain Current | $T_A = 25^\circ C$ | -4.2 |
| | | $T_A = 100^\circ C$ | -3 |
| I_{DM} | Pulsed Drain Current ⁽¹⁾ | -17 | A |
| P_D | Power Dissipation | $T_A = 25^\circ C$ | 1.1 |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient ⁽²⁾ | 119 | $^\circ C/W$ |
| T_J, T_{STG} | Junction & Storage Temperature Range | -55 to 150 | $^\circ C$ |



Electrical Characteristics (T_J = 25°C unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|---|--|--|------|------|------|------|
| Off Characteristics | | | | | | |
| V _{(BR)DSS} | Drain-Source Breakdown Voltage | I _D = -250μA, V _{GS} = 0V | -30 | - | - | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = -30V, V _{GS} = 0V | - | - | 1.0 | μA |
| I _{GSS} | Gate-Body Leakage Current | V _{DS} = 0V, V _{GS} = ±12V | - | - | ±100 | nA |
| On Characteristics | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} = V _{GS} , I _D = -250μA | -0.6 | -0.9 | -1.3 | V |
| R _{DS(on)} | Static Drain-Source ON-Resistance ⁽³⁾ | V _{GS} = -10V, I _D = -4A | - | 36 | 47 | mΩ |
| | | V _{GS} = -4.5V, I _D = -3A | - | 41 | 53 | mΩ |
| | | V _{GS} = -2.5V, I _D = -1A | - | 52 | 68 | mΩ |
| Dynamic Characteristics | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} = 0V, V _{DS} = -15V, f = 1MHz | - | 762 | - | pF |
| C _{oss} | Output Capacitance | | - | 74 | - | pF |
| C _{rss} | Reverse Transfer Capacitance | | - | 61 | - | pF |
| Q _g | Total Gate Charge | V _{GS} = 0 to -4.5V V _{DS} = -15V, I _D = -3A | - | 8 | - | nC |
| Q _{gs} | Gate Source Charge | | - | 2 | - | nC |
| Q _{gd} | Gate Drain ("Miller") Charge | | - | 2 | - | nC |
| Switching Characteristics | | | | | | |
| t _{d(on)} | Turn-On DelayTime | V _{GS} = -4.5V, V _{DD} = -15V I _D = -3A, R _{GEN} = 3Ω | - | 8 | - | ns |
| t _r | Turn-On Rise Time | | - | 16 | - | ns |
| t _{d(off)} | Turn-Off DelayTime | | - | 46 | - | ns |
| t _f | Turn-Off Fall Time | | - | 34 | - | ns |
| Drain-Source Diode Characteristics and Max Ratings | | | | | | |
| I _S | Maximum Continuous Drain to Source Diode Forward Current | | - | - | -4.2 | A |
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | -17 | A |
| V _{SD} | Drain to Source Diode Forward Voltage | V _{GS} = 0V, I _S = -4.2A | - | - | -1.2 | V |
| t _{rr} | Body Diode Reverse Recovery Time | I _F = -3A, di/dt = 100A/us | - | 8 | - | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | | - | 3 | - | nC |

- Notes:
1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
 2. R_{θJA} is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB
 3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 0.5%.

Typical Performance Characteristics

Figure 1: Output Characteristics

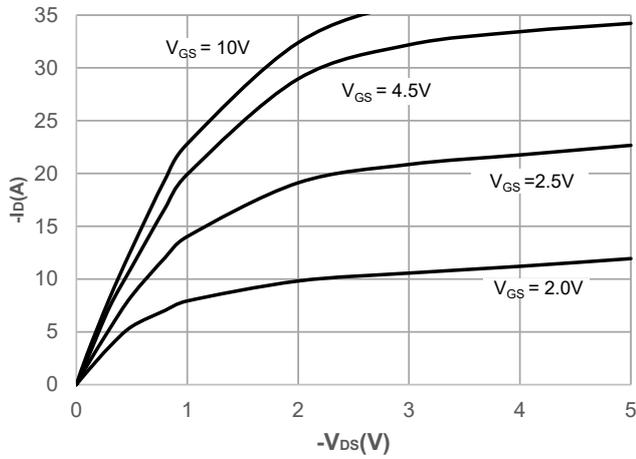


Figure 2: Typical Transfer Characteristics

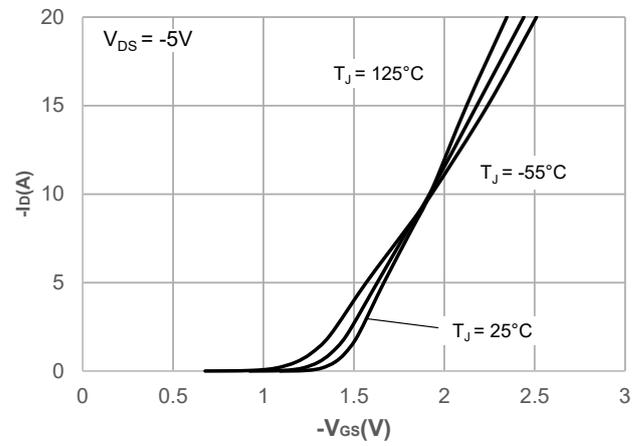


Figure 3: On-resistance vs. Drain Current

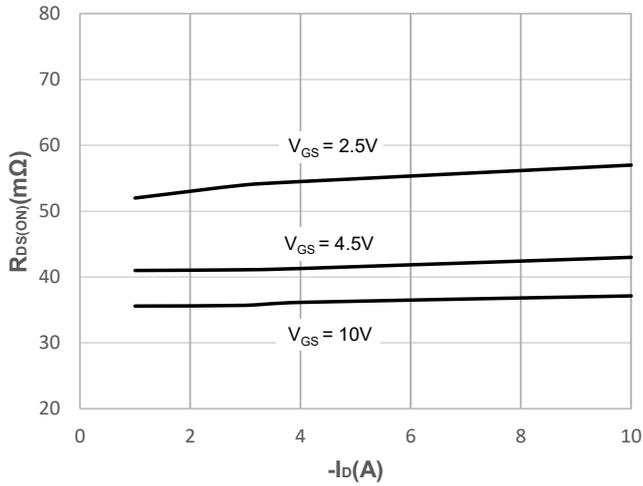


Figure 4: Body Diode Characteristics

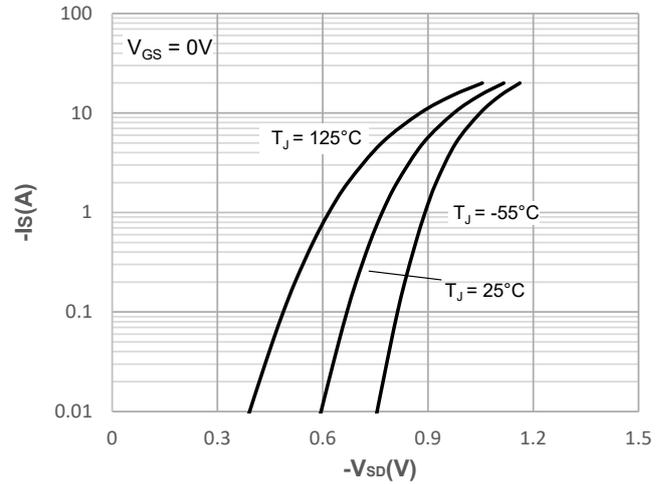


Figure 5: Gate Charge Characteristics

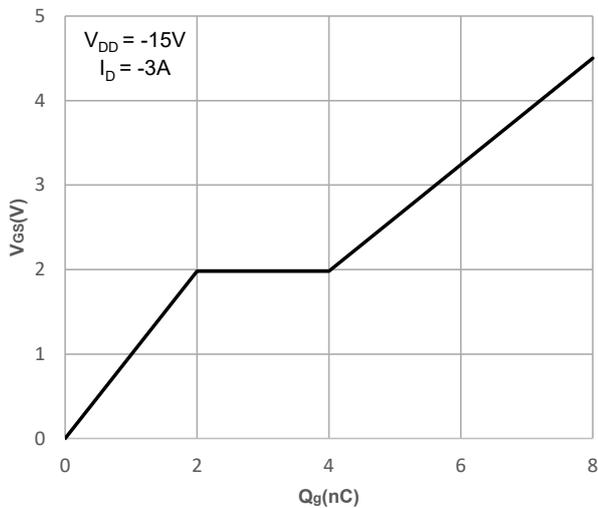
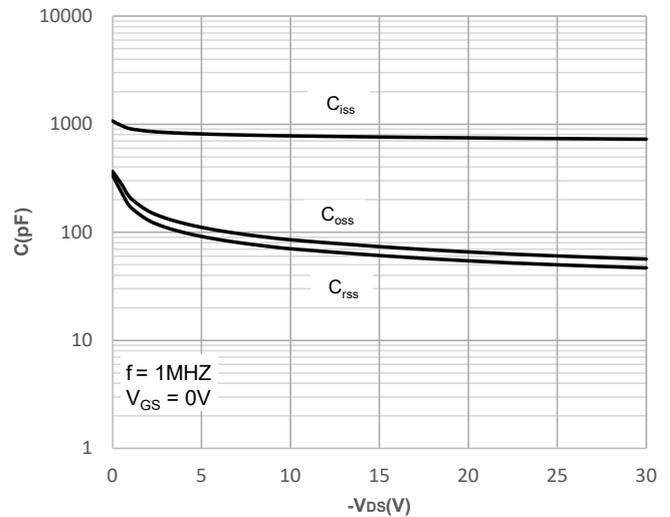


Figure 6: Capacitance Characteristics



Typical Performance Characteristics

Figure 7: Normalized Breakdown voltage vs. Junction Temperature

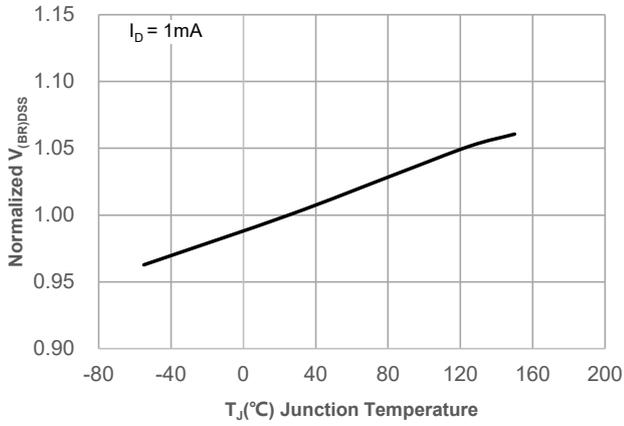


Figure 8: Normalized on Resistance vs. Junction Temperature

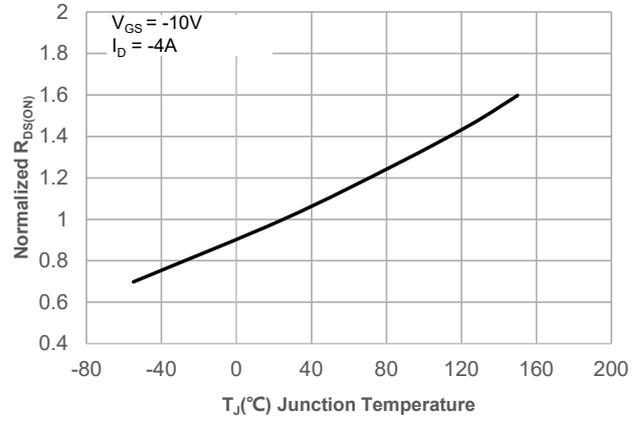


Figure 9: Maximum Safe Operating Area

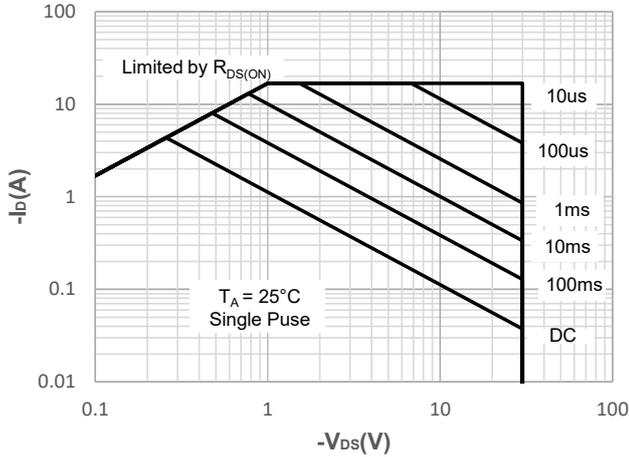


Figure 10: Maximum Continuous Driand Current vs. Ambient Temperature

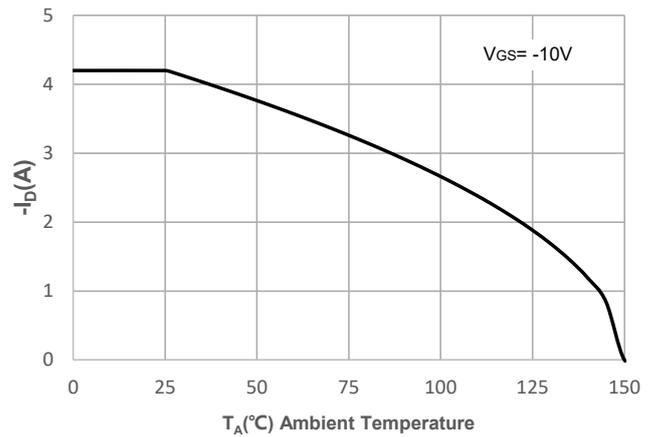


Figure 11: Normalized Maximum Transient Thermal Impedance

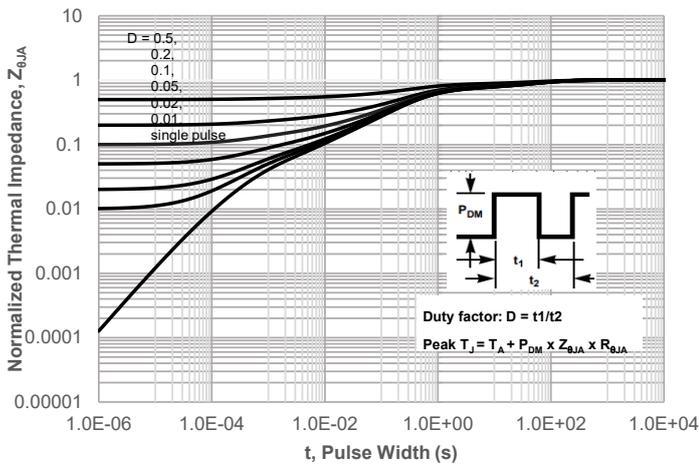
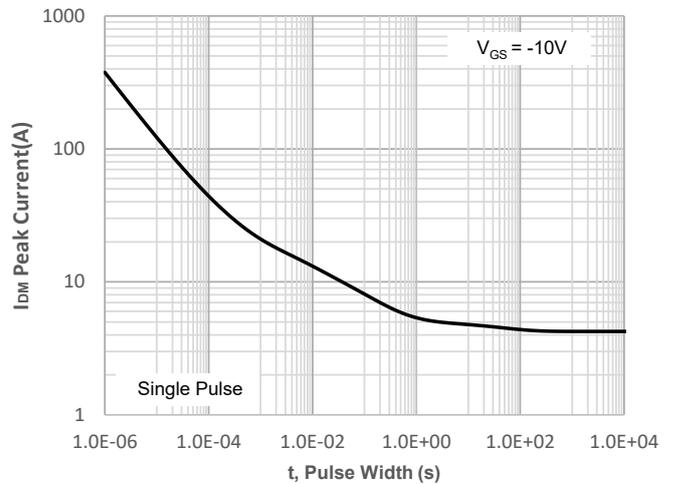


Figure 12: Peak Current Capacity



Test Circuit

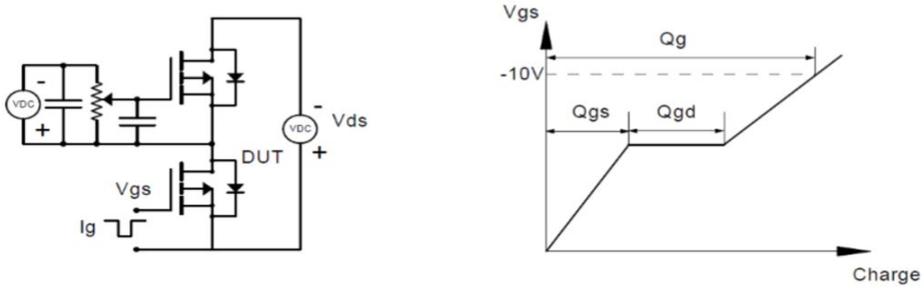


Figure 1: Gate Charge Test Circuit & Waveform

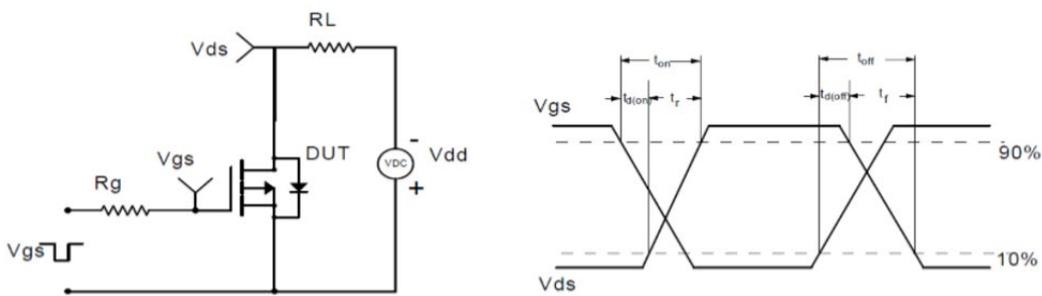


Figure 2: Resistive Switching Test Circuit & Waveform

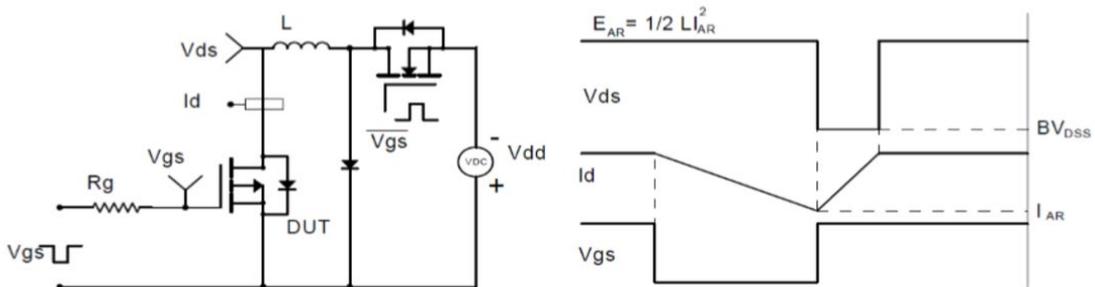


Figure 3: Unclamped Inductive Switching Test Circuit & Waveform

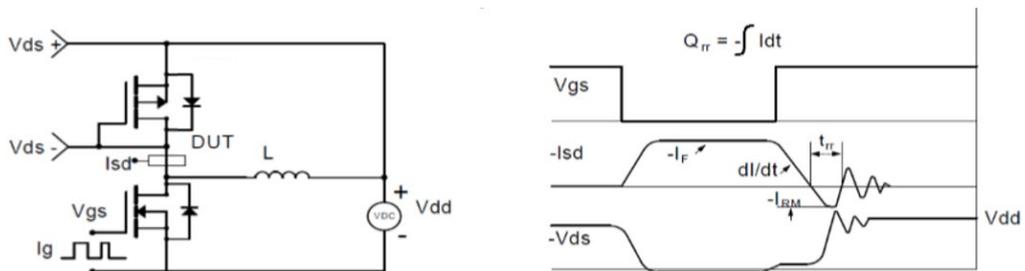
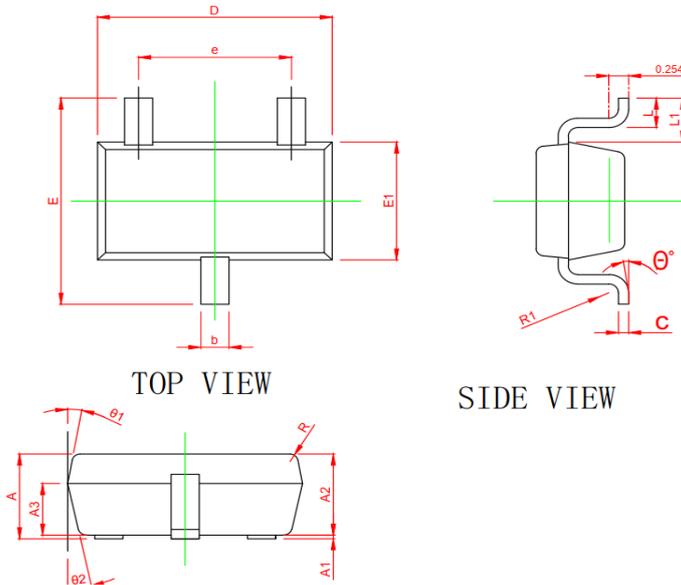


Figure 4: Diode Recovery Test Circuit & Waveform

Package Mechanical Data(SOT-23-3L)



| SYMBOL | MILLIMETER | | |
|------------|------------|------|------|
| | MIN | NOM | MAX |
| A | - | - | 1.25 |
| * A1 | 0.02 | - | 0.10 |
| * A2 | 1.05 | 1.10 | 1.15 |
| A3 | 0.65 | 0.70 | 0.75 |
| * b | 0.30 | 0.35 | 0.45 |
| * c | 0.127 BSC | | |
| * D | 2.87 | 2.92 | 2.97 |
| * E | 2.72 | 2.80 | 2.88 |
| * E1 | 1.55 | 1.60 | 1.65 |
| * e | 1.85 | 1.90 | 1.95 |
| * L | 0.32 | 0.40 | 0.48 |
| * L1 | 0.55 | 0.60 | 0.65 |
| R | 0.10 REF | | |
| R1 | 0.12 REF | | |
| * θ | 0 | -- | 8° |
| $\theta 1$ | 8° | 10° | 12° |
| $\theta 2$ | 10° | 12° | 14° |

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